

**Search Notes**

Application/Control No.

10/538,540

Examiner

RIP A. LEE

Applicant(s)/Patent under  
Reexamination

MIHAN ET AL.

Art Unit

1796

**SEARCHED**

Class	Subclass	Date	Examiner
528	396	7/19/2008	RL
526	348	7/19/2008	RL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	7/19/2008	RL
palm - updated inventor search	7/19/2008	RL